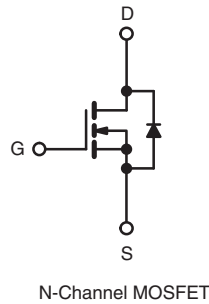
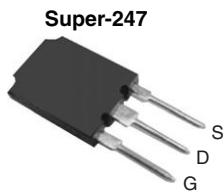


## Power MOSFET

PRODUCT SUMMARY		
$V_{DS}$ (V)	500	
$R_{DS(on)}$ ( $\Omega$ )	$V_{GS} = 10$ V	0.087
$Q_g$ (Max.) (nC)	380	
$Q_{gs}$ (nC)	80	
$Q_{gd}$ (nC)	190	
Configuration	Single	



### FEATURES

- Superfast Body Diode Eliminates the Need for External Diodes in ZVS Applications
- Lower Gate Charge Results in Simpler Drive Requirements
- Enhanced  $dV/dt$  Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise Immunity
- Compliant to RoHS Directive 2002/95/EC



**RoHS\***  
COMPLIANT

### APPLICATIONS

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control Applications

ORDERING INFORMATION	
Package	Super-247
Lead (Pb)-free	IRFPS40N50LPbF
	SiHFPS40N50L-E3
SnPb	IRFPS40N50L
	SiHFPS40N50L

ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ\text{C}$ , unless otherwise noted)				
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	$V_{DS}$	500	V	
Gate-Source Voltage	$V_{GS}$	$\pm 30$		
Continuous Drain Current	$V_{GS}$ at 10 V	$T_C = 25^\circ\text{C}$	A	
		$T_C = 100^\circ\text{C}$		
Pulsed Drain Current <sup>a</sup>	$I_{DM}$	180		
Linear Derating Factor		4.3	W/ $^\circ\text{C}$	
Single Pulse Avalanche Energy <sup>b</sup>	$E_{AS}$	920	mJ	
Repetitive Avalanche Current <sup>a</sup>	$I_{AR}$	46	A	
Repetitive Avalanche Energy <sup>a</sup>	$E_{AR}$	54	mJ	
Maximum Power Dissipation	$T_C = 25^\circ\text{C}$	$P_D$	540	W
Peak Diode Recovery $dV/dt^c$		$dV/dt$	34	V/ns
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to + 150	$^\circ\text{C}$	
Soldering Recommendations (Peak Temperature)	for 10 s	300 <sup>d</sup>		

#### Notes


- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.86$  mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 46$  A (see fig. 12).
- $I_{SD} \leq 46$  A,  $di/dt \leq 550$  A/ $\mu\text{s}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150^\circ\text{C}$ .
- 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient <sup>a</sup>	$R_{thJA}$	-	40	°C/W
Case-to-Sink, Flat, Greased Surface	$R_{thCS}$	0.24	-	
Maximum Junction-to-Case (Drain) <sup>a</sup>	$R_{thJC}$	-	0.23	

### Note

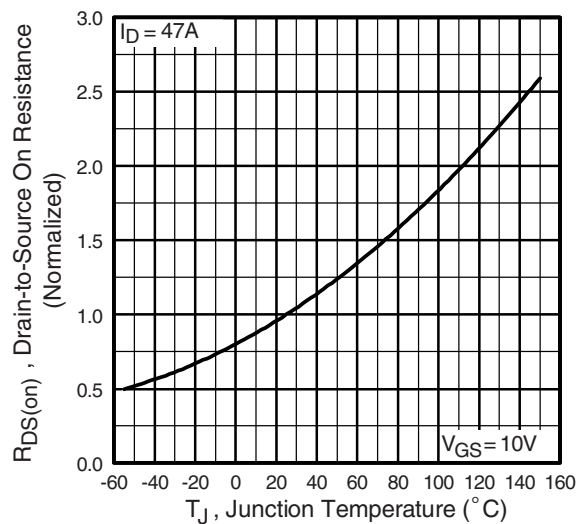
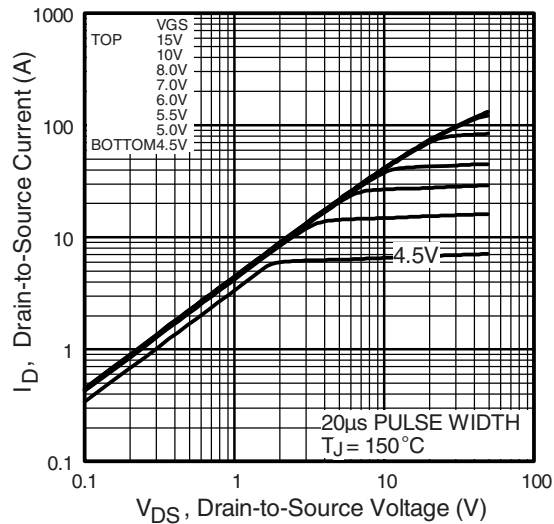
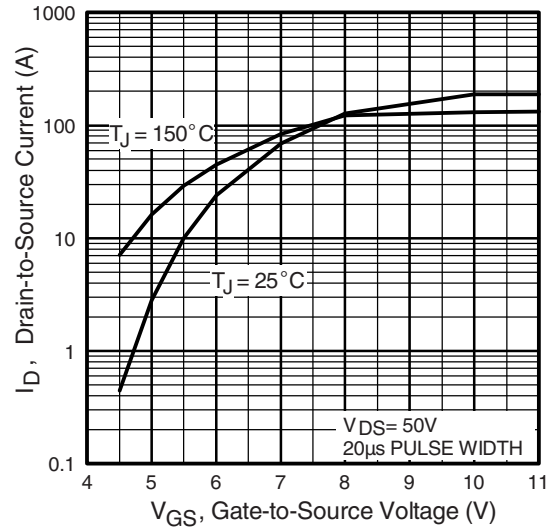
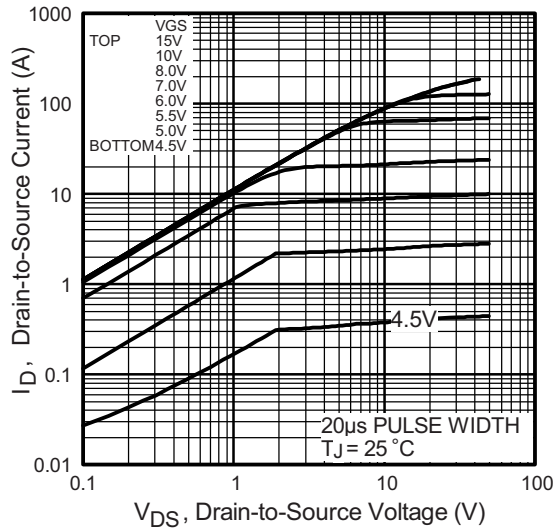
a.  $R_{th}$  is measured at  $T_J$  approximately 90 °C.

SPECIFICATIONS ( $T_J = 25$ °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0$ V, $I_D = 250$ $\mu$ A	500	-	-	V	
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to 25 °C, $I_D = 1$ mA	-	0.60	-	V/°C	
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250$ $\mu$ A	3.0	-	5.0	V	
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 30$ V	-	-	$\pm 100$	nA	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 500$ V, $V_{GS} = 0$ V	-	-	50	$\mu$ A	
		$V_{DS} = 400$ V, $V_{GS} = 0$ V, $T_J = 125$ °C	-	-	2.0	mA	
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10$ V, $I_D = 28$ A <sup>b</sup>	-	0.087	0.100	$\Omega$	
Forward Transconductance	$g_{fs}$	$V_{DS} = 50$ V, $I_D = 46$ A	21	-	-	S	
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0$ V, $V_{DS} = 25$ V, $f = 1.0$ MHz, see fig. 5	-	8110	-	pF	
Output Capacitance	$C_{oss}$		-	960	-		
Reverse Transfer Capacitance	$C_{rss}$		-	130	-		
Output Capacitance	$C_{oss}$	$V_{GS} = 0$ V	$V_{DS} = 1.0$ V, $f = 1.0$ MHz	-	11200	-	
Effective Output Capacitance	$C_{oss\ eff.}$		$V_{DS} = 400$ V, $f = 1.0$ MHz	-	240	-	
Effective Output Capacitance (Energy Related)	$C_{oss\ eff. (ER)}$		$V_{DS} = 0$ V to 400 V <sup>c</sup>	-	310	-	
Total Gate Charge	$Q_g$	$V_{GS} = 10$ V	$I_D = 46$ A, $V_{DS} = 400$ V, see fig. 7 and 15 <sup>b</sup>	-	-	380	nC
Gate-Source Charge	$Q_{gs}$			-	-	80	
Gate-Drain Charge	$Q_{gd}$			-	-	190	
Internal Gate Resistance	$R_G$	$f = 1$ MHz, open drain		-	0.90	-	$\Omega$
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 250$ V, $I_D = 46$ A, $R_G = 0.85$ $\Omega$ , $V_{GS} = 10$ V, see fig. 14a and 14b <sup>b</sup>	-	27	-	ns	
Rise Time	$t_r$		-	170	-		
Turn-Off Delay Time	$t_{d(off)}$		-	50	-		
Fall Time	$t_f$		-	69	-		
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode 	-	-	46	A	
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$		-	-	180		
Body Diode Voltage	$V_{SD}$	$T_J = 25$ °C, $I_S = 46$ A, $V_{GS} = 0$ V <sup>b</sup>	-	-	1.5	V	
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25$ °C, $I_F = 46$ A	-	170	250	ns	
		$T_J = 125$ °C, $dI/dt = 100$ A/ $\mu$ s <sup>b</sup>	-	220	330		
Body Diode Reverse Recovery Charge	$Q_{rr}$	$T_J = 25$ °C, $I_S = 46$ A, $V_{GS} = 0$ V <sup>b</sup>	-	705	1060	nC	
		$T_J = 125$ °C, $dI/dt = 100$ A/ $\mu$ s <sup>b</sup>	-	1.3	2.0		
Reverse Recovery Current	$I_{RRM}$	$T_J = 25$ °C	-	9.0	-	A	
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					

### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Pulse width  $\leq 400$   $\mu$ s; duty cycle  $\leq 2$  %.
- $C_{oss\ eff.}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .  
 $C_{oss\ eff. (ER)}$  is a fixed capacitance that stores the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .

## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



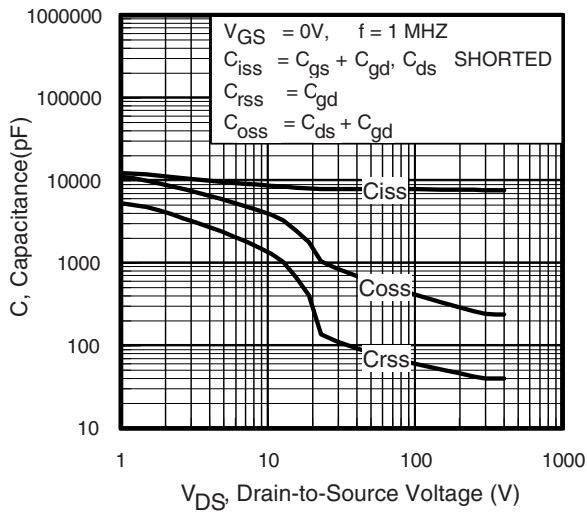


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

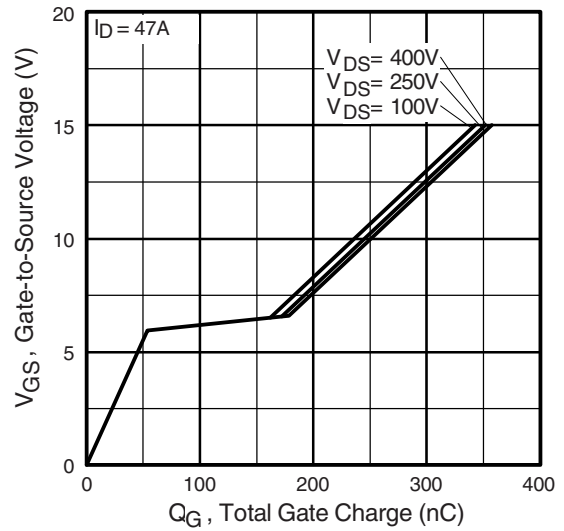


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

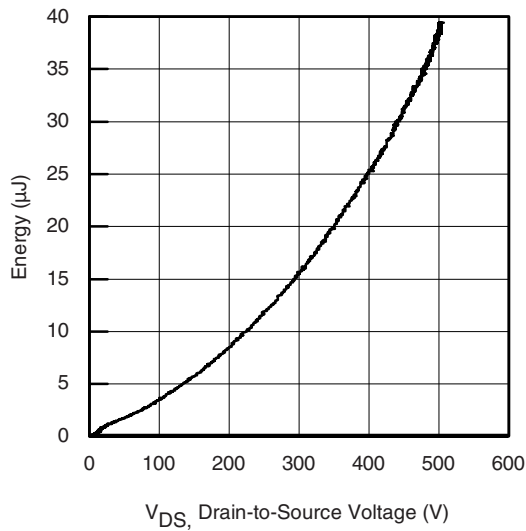


Fig. 6 - Typical Output Capacitance Stored Energy vs.  $V_{DS}$

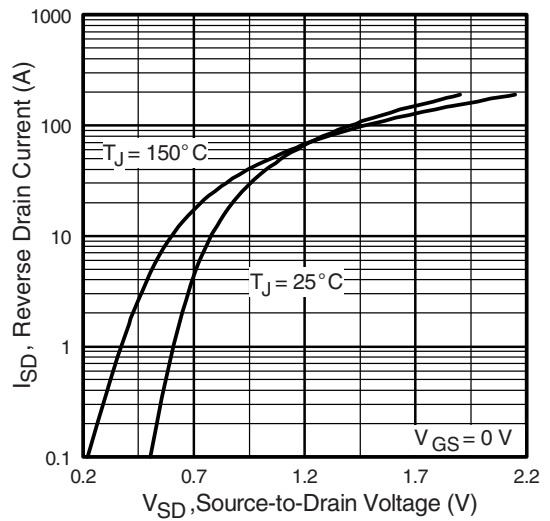


Fig. 8 - Typical Source Drain Diode Forward Voltage

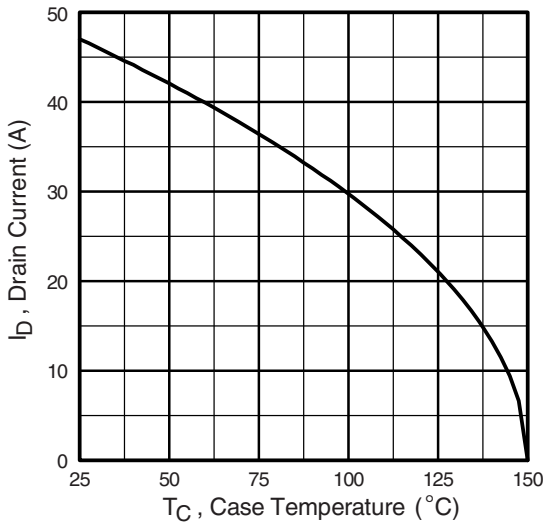


Fig. 9 - Maximum Drain Current vs. Case Temperature

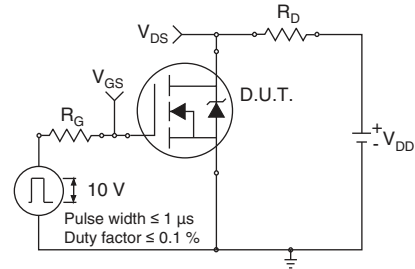


Fig. 10a - Switching Time Test Circuit

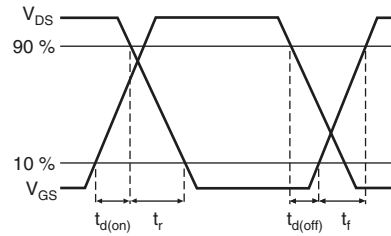


Fig. 10b - Switching Time Waveforms

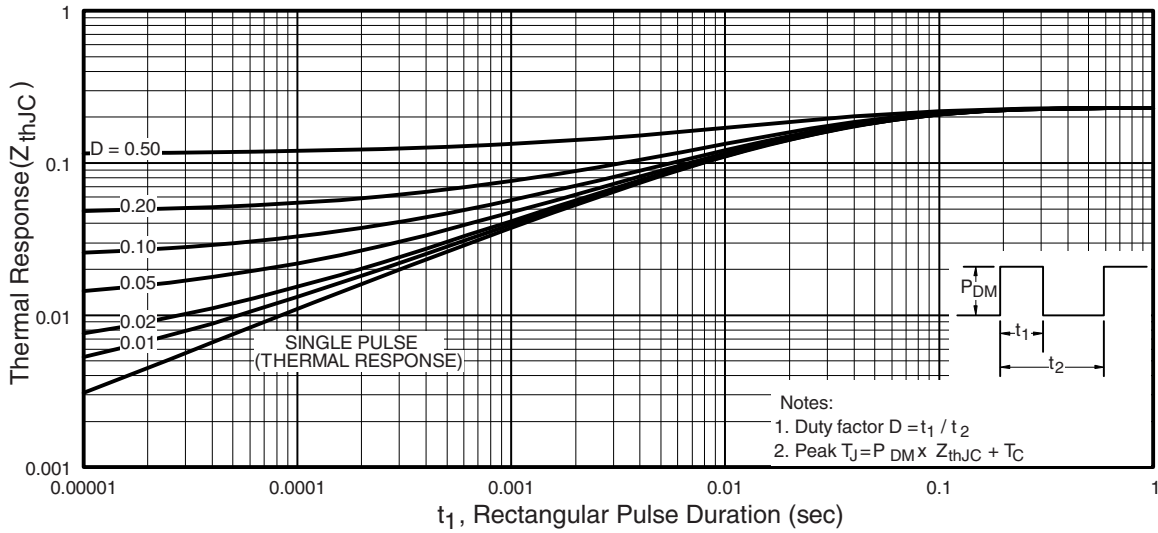


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

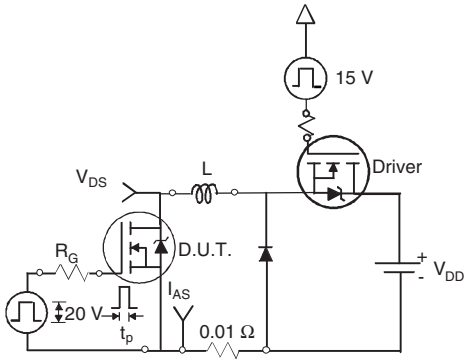


Fig. 12a - Unclamped Inductive Test Circuit

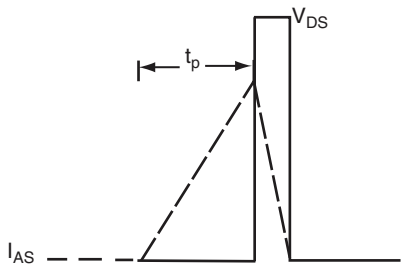


Fig. 12b - Unclamped Inductive Waveforms

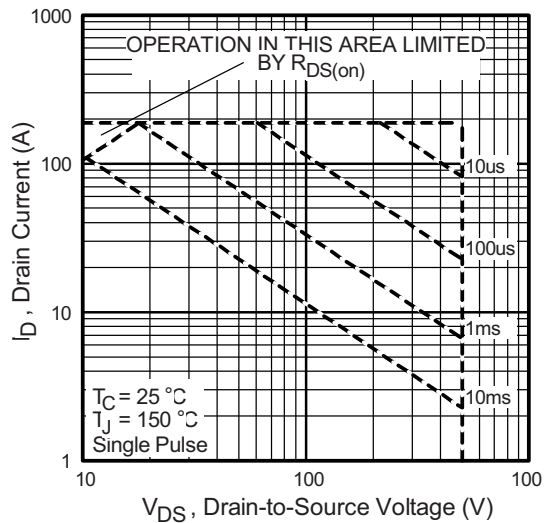


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

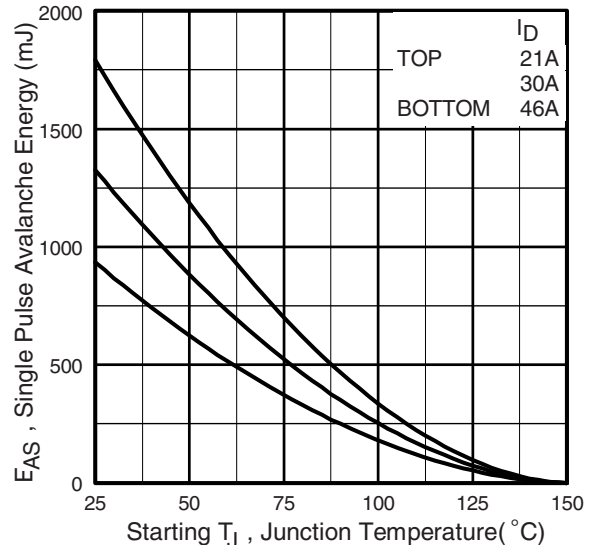


Fig. 12d - Maximum Safe Operating Area

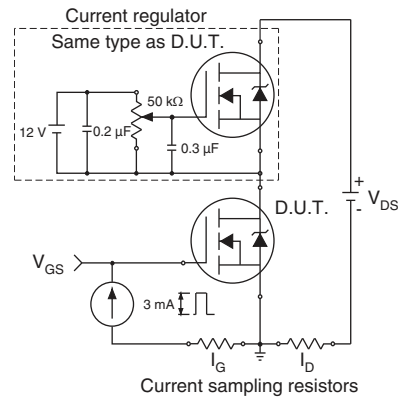


Fig. 13a - Gate Charge Test Circuit

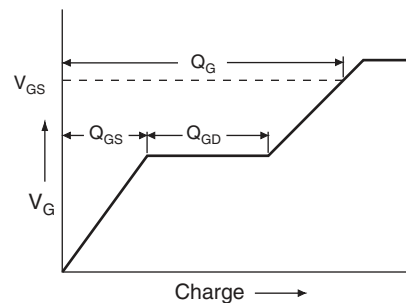
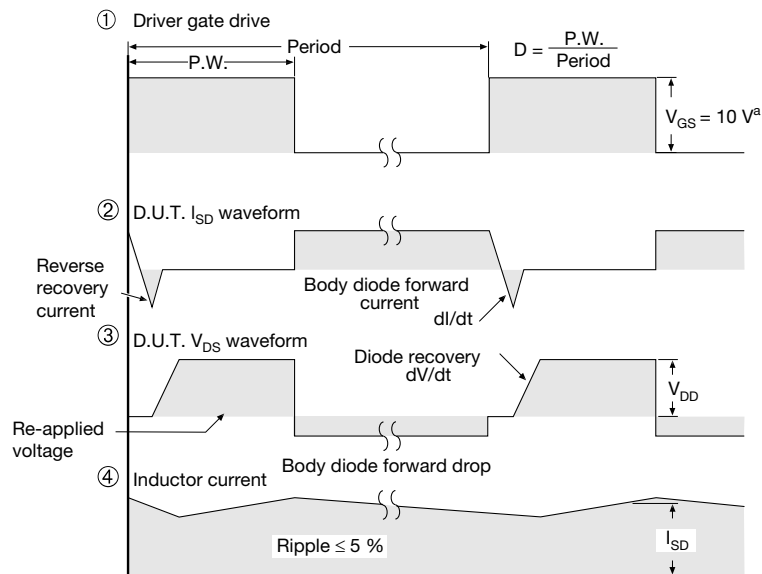
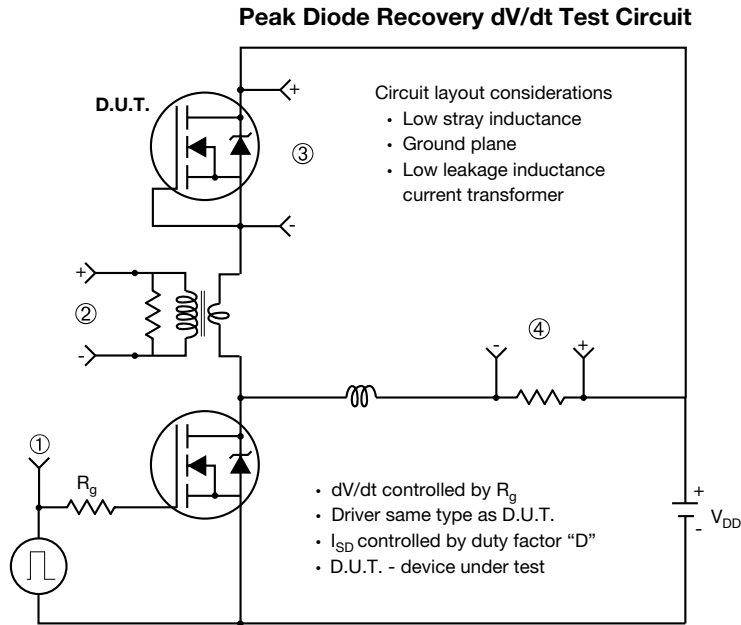


Fig. 13b - Basic Gate Charge Waveform



**Note**

a.  $V_{GS} = 5 V$  for logic level devices

**Fig. 14 - For N-Channel**

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see [www.vishay.com/ppg?91260](http://www.vishay.com/ppg?91260).



## Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and/or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk and agree to fully indemnify and hold Vishay and its distributors harmless from and against any and all claims, liabilities, expenses and damages arising or resulting in connection with such use or sale, including attorneys fees, even if such claim alleges that Vishay or its distributor was negligent regarding the design or manufacture of the part. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.